## Notice of References Cited Application/Control No. 10/707,749 Examiner Y. J. Han Applicant(s)/Patent Under Reexamination FUNG ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,301,130	10-2001	Aiello et al.	363/37
	В	US-5,847,941	12-1998	Taguchi et al.	363/21.03
	С	US-5,795,595	08-1998	Beeck et al.	425/198
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	R					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	x					

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